Customer No. 22,852 Attorney Docket No. 6854-51

Group Art Unit: Not Yet Assigned

Confirmation No.: Not Yet Assigned

Examiner: Not Yet Assigned

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Masaaki MORI et al.

Application No.: 10/577,451

Filed: April 27, 2006

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For: GAS INJECTION AMOUNT
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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

CORRECTED INFORMATION DISCLOSURE STATEMENT

On September 13, 2006 the below-mentioned attorney submitted an Information Disclosure Statement stating U.S. 4,247,773 is an English counterpart of JP 55-112546 which is incorrect. This U.S. Patent document is actually an English counterpart of JP 55-104740 A.

Also, a typographical error has been noted in the spelling of the author's last name for the first literature reference on page 2 of the Form PTO/SB/08. The correct spelling is TETSUO rather than TETSYO. A corrected Form PTO/SB/08 is attached.

If there is any fee due in connection with the filing of this Corrected Statement, please charge the fee to our Deposit Account No. 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW, GARRETT & DUNNER, L.L.P.

Dated: October 3, 2006

Arthur S. Garrett Reg. No. 20,338 Tel: 202 408-2091

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IDS Form PTO/SB/08: Substitute for form 1449A/PTO

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CORRECTED INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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